Search Notes

Application No.	Applicant(s)	
10/016,834	DOCHEZ ET AL	
Examiner	Art Unit	
Aaron D Matthew	2114	

SEARCHED					
Class	Subclass	Date	Examiner		
714	38	3/17/2005	Aan		
719	328,329	3/17/2005	AMY		
717	124,130	3/20/2005	Any		
717	128	3/20/2005	AMY AMY AMY		
74	37	3/20/2005	Apry		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search: Results Attached	3/16/2005	sou		
East Search: Results Attached	3/16/2005 1 3/20/2005	san		
Consulted with Primary Examiner, Bryce Bonzo	3/18/2005	Som		
Consulted with Examiners, Michael Maskulinski, Marc Duncan, Gabe Chu	3/18/2005	Aom		
Consulted with Examiner, Tim Bonura	3/20/2005	Aom		
IEEE/ACM NPL Search: (J2EE, Java, coverage, test, API, application, portable, integrate)	3/20/2005	Am		